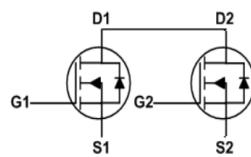



**• General Description**

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . Two N Channel MOSFET inside.

**• Product Summary**


$V_{DS1} = 60V$   
 $V_{DS2} = 60V$   
 $R_{DS(ON)1} = 28m\Omega$   
 $R_{DS(ON)2} = 28m\Omega$   
 $I_{D1} = 25A$   
 $I_{D2} = 25A$

**• Features**

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Dual DIE in one package


**• Application**

- Mobile device battery charging and discharging
- Battery protection switch

TO-252-4

**• Ordering Information:**

Part NO.	ZMD68602D
Marking	ZMD68602
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2500

**• Absolute Maximum Ratings ( $T_c = 25^\circ C$ )**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D @ T_c = 25^\circ C$	25	A
	$I_D @ T_c = 75^\circ C$	19	A
	$I_D @ T_c = 100^\circ C$	15.8	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	75	A
Total Power Dissipation( $T_c = 25^\circ C$ )	$P_D @ T_c = 25^\circ C$	50	W
Total Power Dissipation( $T_A = 25^\circ C$ )	$P_D @ T_A = 25^\circ C$	1.25	W
Operating Junction Temperature	$T_J$	-55 to 150	$^\circ C$
Storage Temperature	$T_{STG}$	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy	$E_{AS}$	75	mJ


**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	2.3	° C/W
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	° C/W
Soldering temperature, wavesoldering for 10s	T <sub>sold</sub>	-	-	265	° C

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	60			V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2	1.8	2.5	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			1.0	uA
Gate- Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V ,V <sub>DS</sub> =0V			±100	nA
Static Drain-source On Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =12A		28	34	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A		31	40	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =25V, I <sub>D</sub> =10A		5		s
Source-drain voltage	V <sub>SD</sub>	I <sub>S</sub> =12A			1.28	V

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V f = 1MHz	-	1430	-	pF
Output capacitance	C <sub>oss</sub>		-	160	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	115	-	

**•Gate Charge characteristics(T<sub>a</sub> = 25°C)**

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q <sub>g</sub>	V <sub>DD</sub> = 25V I <sub>D</sub> = 5A V <sub>GS</sub> = 10V	-	25	-	nC
Gate - Source charge	Q <sub>gs</sub>		-	4	-	
Gate - Drain charge	Q <sub>gd</sub>		-	9	-	

Note: ① Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% ;



Fig.1 Maximum Continuous Drain Current

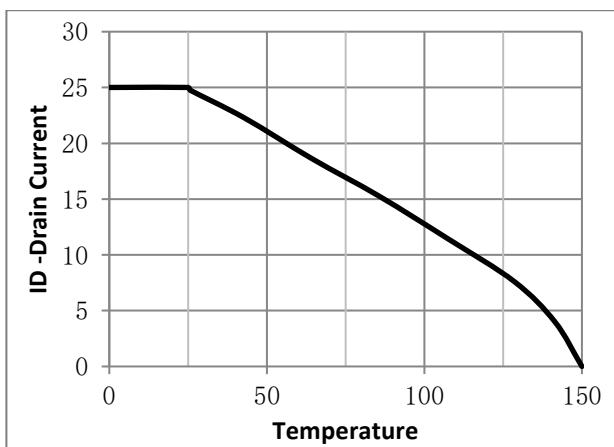


Fig.2 Typical output Characteristics

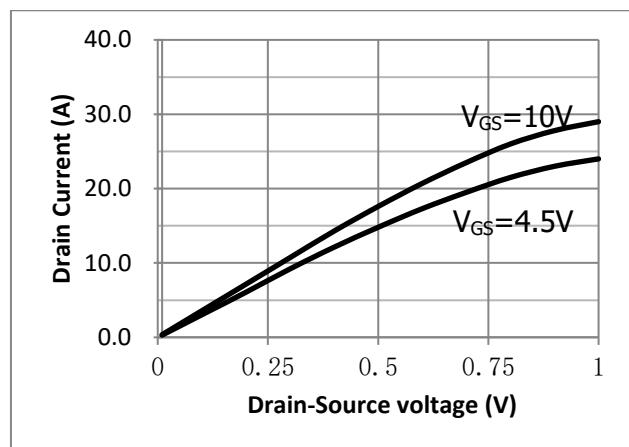


Fig.3 Threshold Voltage V.S Junction Temperature

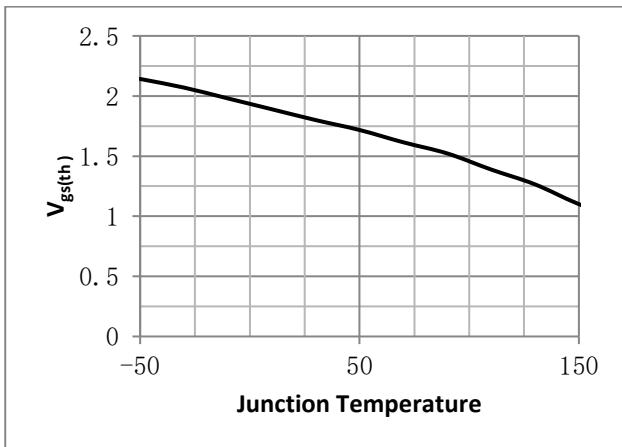


Fig.4 Resistance V.S Drain Current

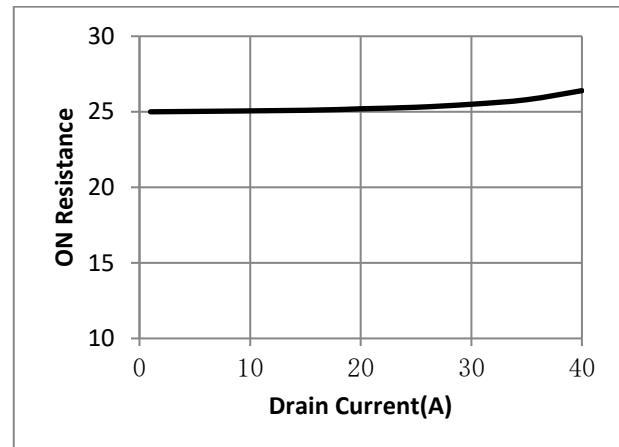


Fig.5 On-Resistance VS Gate Source Voltage

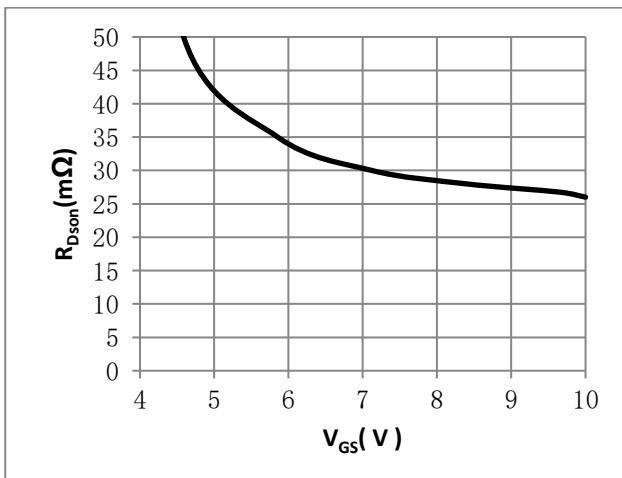
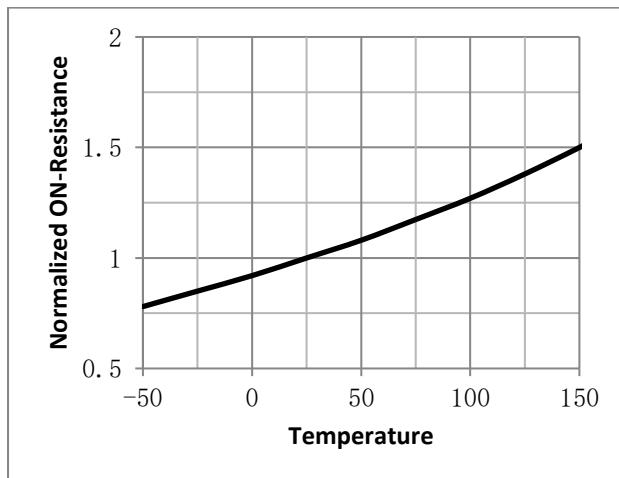


Fig.6 On-Resistance V.S Junction Temperature





## •Dimensions(TO-252-4)

Unit: mm

